

### Features

- High current capability
- High frequency operation
- Low  $C_{RES}/C_{IES}$  ratio (no cross-conduction susceptibility)
- Very soft ultra fast recovery antiparallel diode

### Applications

- High frequency inverters
- SMPS and PFC in both hard switching and resonant topologies
- UPS
- Motor drivers

### Description

Using the latest high voltage technology based on a patented strip layout, STMicroelectronics has designed an advanced family of IGBTs, the PowerMESH™ IGBTs, with outstanding performances. The suffix “V” identifies a family optimized for high frequency.

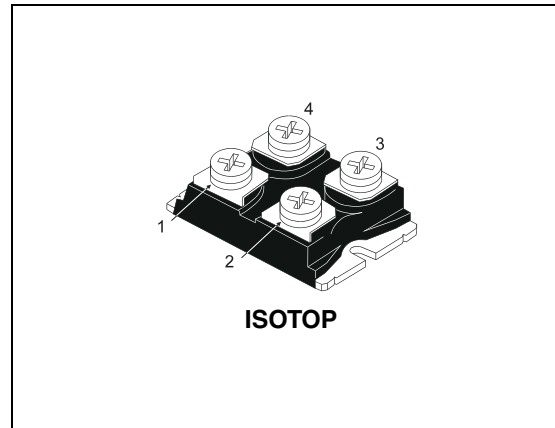


Figure 1. Internal schematic diagram

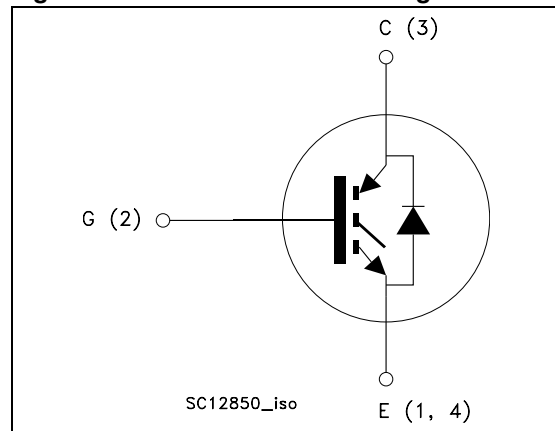


Table 1. Device summary

Order code	Marking	Package	Packaging
STGE50NC60VD	GE50NC60VD	ISOTOP	Tube

## Contents

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# 1 Electrical ratings

**Table 2. Absolute maximum ratings**

Symbol	Parameter	Value	Unit
$V_{CES}$	Collector-emitter voltage ( $V_{GE} = 0$ )	600	V
$I_C^{(1)}$	Collector current (continuous) at $T_C = 25\text{ °C}$	90	A
$I_C^{(1)}$	Collector current (continuous) at $T_C = 100\text{ °C}$	50	A
$I_{CL}^{(2)}$	Turn-off latching current	200	A
$I_{CP}^{(3)}$	Pulsed collector current	200	A
$V_{GE}$	Gate-emitter voltage	$\pm 20$	V
$I_F$	Diode RMS forward current at $T_C=25\text{ °C}$	30	A
$I_{FSM}$	Surge non repetitive forward current $t_p = 10\text{ ms}$ sinusoidal	120	A
$P_{TOT}$	Total dissipation at $T_C = 25\text{ °C}$	260	W
$T_J$	Operating junction temperature	-55 to 150	$^{\circ}\text{C}$

1. Calculated according to the iterative formula

$$I_C(T_C) = \frac{T_{j(\max)} - T_C}{R_{thj-c} \times V_{CE(sat)(\max)}(T_{j(\max)}, I_C(T_C))}$$

2.  $V_{clamp} = 80\%$  of  $V_{CES}$ ,  $T_j = 150\text{ °C}$ ,  $R_G = 10\ \Omega$ ,  $V_{GE} = 15\text{ V}$

3. Pulse width limited by max. junction temperature allowed

**Table 3. Thermal data**

Symbol	Parameter	Value	Unit
$R_{thj-case}$	Thermal resistance junction-case IGBT	0.48	$^{\circ}\text{C/W}$
$R_{thj-case}$	Thermal resistance junction-case diode	1.6	$^{\circ}\text{C/W}$
$R_{thj-amb}$	Thermal resistance junction-amb	30	$^{\circ}\text{C/W}$

## 2 Electrical characteristics

( $T_J = 25\text{ °C}$  unless otherwise specified)

**Table 4. Static**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)CES}$	Collector-emitter breakdown voltage ( $V_{GE} = 0$ )	$I_C = 1\text{ mA}$	600			V
$V_{CE(sat)}$	Collector-emitter saturation voltage	$V_{GE} = 15\text{ V}, I_C = 40\text{ A}$		1.9	2.5	V
		$V_{GE} = 15\text{ V}, I_C = 40\text{ A}, T_J = 125\text{ °C}$		1.7		V
$V_{GE(th)}$	Gate threshold voltage	$V_{CE} = V_{GE}, I_C = 250\text{ }\mu\text{A}$	3.75		5.75	V
$I_{CES}$	Collector cut-off current ( $V_{GE} = 0$ )	$V_{CE} = 600\text{ V}$			150	$\mu\text{A}$
		$V_{CE} = 600\text{ V}, T_J = 125\text{ °C}$			1	mA
$I_{GES}$	Gate-emitter leakage current ( $V_{CE} = 0$ )	$V_{GE} = \pm 20\text{ V}$			$\pm 100$	nA
$g_{fs}^{(1)}$	Forward transconductance	$V_{CE} = 15\text{ V}, I_C = 20\text{ A}$		20		S

1. Pulsed: pulse duration= 300  $\mu\text{s}$ , duty cycle 1.5%

**Table 5. Dynamic**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$C_{ies}$	Input capacitance	$V_{CE} = 25\text{ V}, f = 1\text{ MHz}, V_{GE} = 0$		4550		pF
$C_{oes}$	Output capacitance		-	350	-	pF
$C_{res}$	Reverse transfer capacitance				105	
$Q_g$	Total gate charge	$V_{CE} = 390\text{ V}, I_C = 40\text{ A},$		214		nC
$Q_{ge}$	Gate-emitter charge	$V_{GE} = 15\text{ V},$	-	30	-	nC
$Q_{gc}$	Gate-collector charge	see <a href="#">Figure 17</a>		96		nC

**Table 6. Switching on/off (inductive load)**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$	Turn-on delay time	$V_{CC} = 390\text{ V}$ , $I_C = 40\text{ A}$		43		ns
$t_r$	Current rise time	$R_G = 3.3\ \Omega$ , $V_{GE} = 15\text{ V}$ ,	-	17	-	ns
$(di/dt)_{on}$	Turn-on current slope	see <a href="#">Figure 16</a>		2060		A/ $\mu$ s
$t_{d(on)}$	Turn-on delay time	$V_{CC} = 390\text{ V}$ , $I_C = 40\text{ A}$		42		ns
$t_r$	Current rise time	$R_G = 3.3\ \Omega$ , $V_{GE} = 15\text{ V}$ ,	-	19	-	ns
$(di/dt)_{on}$	Turn-on current slope	$T_j = 125\text{ }^\circ\text{C}$ see <a href="#">Figure 16</a>		1900		A/ $\mu$ s
$t_{r(Voff)}$	Off voltage rise time	$V_{CC} = 390\text{ V}$ , $I_C = 40\text{ A}$		25		ns
$t_{d(Voff)}$	Turn-off delay time	$R_G = 3.3\ \Omega$ , $V_{GE} = 15\text{ V}$ ,	-	140	-	ns
$t_f$	Current fall time	see <a href="#">Figure 16</a>		45		ns
$t_{r(Voff)}$	Off voltage rise time	$V_{CC} = 390\text{ V}$ , $I_C = 40\text{ A}$		60		ns
$t_{d(Voff)}$	Turn-off delay time	$R_G = 3.3\ \Omega$ , $V_{GE} = 15\text{ V}$ ,	-	170	-	ns
$t_f$	Current fall time	$T_j = 125\text{ }^\circ\text{C}$ see <a href="#">Figure 16</a>		77		ns

**Table 7. Switching energy (inductive load)**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$E_{on}^{(1)}$	Turn-on switching losses	$V_{CC} = 390\text{ V}$ , $I_C = 40\text{ A}$		330	450	$\mu$ J
$E_{off}^{(2)}$	Turn-off switching losses	$R_G = 3.3\ \Omega$ , $V_{GE} = 15\text{ V}$ ,	-	720	970	$\mu$ J
$E_{ts}$	Total switching losses	see <a href="#">Figure 18</a>		1050	1420	$\mu$ J
$E_{on}^{(1)}$	Turn-on switching losses	$V_{CC} = 390\text{ V}$ , $I_C = 40\text{ A}$		640		$\mu$ J
$E_{off}^{(2)}$	Turn-off switching losses	$R_G = 3.3\ \Omega$ , $V_{GE} = 15\text{ V}$ ,	-	1400		$\mu$ J
$E_{ts}$	Total switching losses	$T_j = 125\text{ }^\circ\text{C}$ see <a href="#">Figure 18</a>		2040		$\mu$ J

1.  $E_{on}$  is the turn-on losses when a typical diode is used in the test circuit in [Figure 18](#) If the IGBT is offered in a package with a co-pak diode, the co-pak diode is used as external diode. IGBTs & Diode are at the same temperature (25 °C and 125 °C)

2. Turn-off losses include also the tail of the collector current

Table 8. Collector-emitter diode

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_F$	Forward on-voltage	$I_F = 20\text{ A}$	-	1.5	2.2	V
		$I_F = 20\text{ A}, T_j = 125^\circ\text{C}$		1		V
$t_{rr}$	Reverse recovery time	$I_F = 20\text{ A}, V_R = 40\text{ V},$	-	44		ns
$Q_{rr}$	Reverse recovery charge	$di/dt = 100\text{ A}/\mu\text{s}$		66		nC
$I_{rrm}$	Reverse recovery current	see <a href="#">Figure 19</a>		3		A
$t_{rr}$	Reverse recovery time	$I_F = 20\text{ A}, V_R = 40\text{ V},$	-	88		ns
$Q_{rr}$	Reverse recovery charge	$T_j = 125^\circ\text{C}, di/dt = 100\text{ A}/\mu\text{s}$		237		nC
$I_{rrm}$	Reverse recovery current	see <a href="#">Figure 19</a>		5.4		A

## 2.1 Electrical characteristics (curves)

Figure 2. Output characteristics

Figure 3. Transfer characteristics

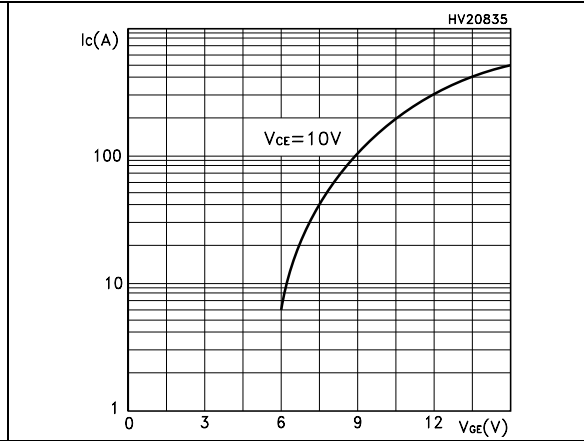
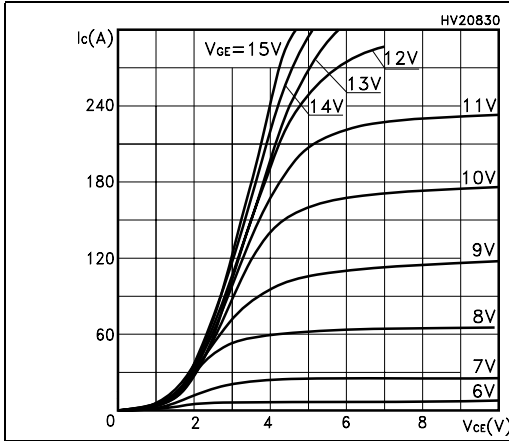


Figure 4. Transconductance

Figure 5. Collector-emitter on voltage vs temperature

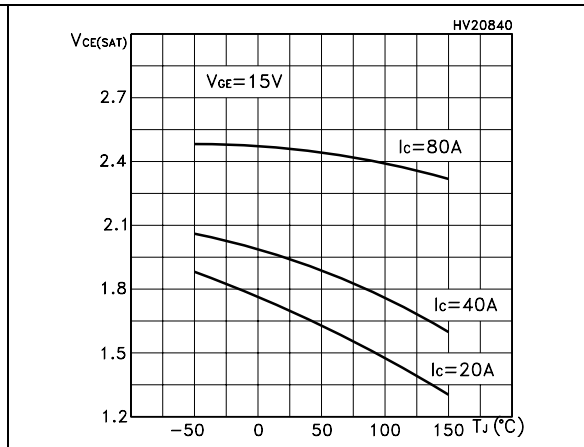
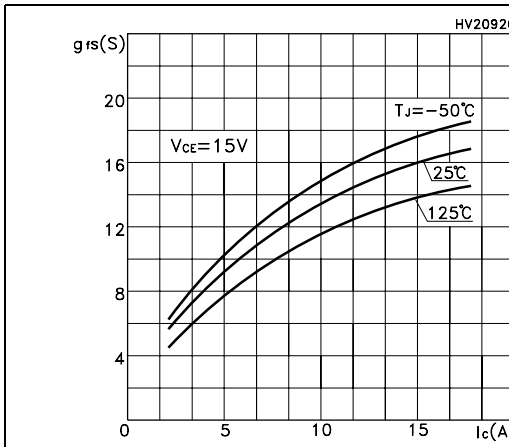


Figure 6. Collector-emitter on voltage vs collector current

Figure 7. Normalized gate threshold vs temperature

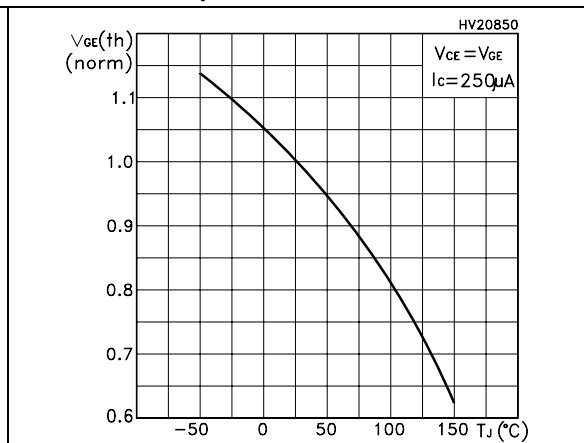
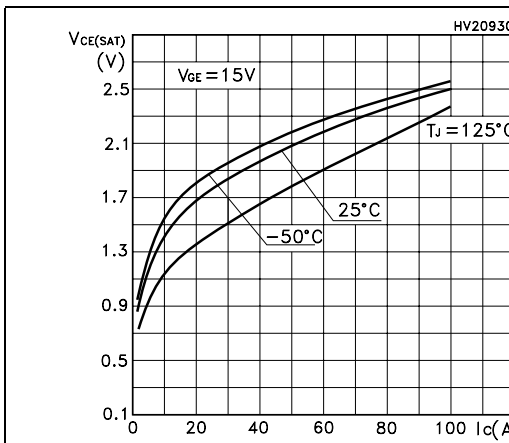


Figure 8. Normalized breakdown voltage vs temperature

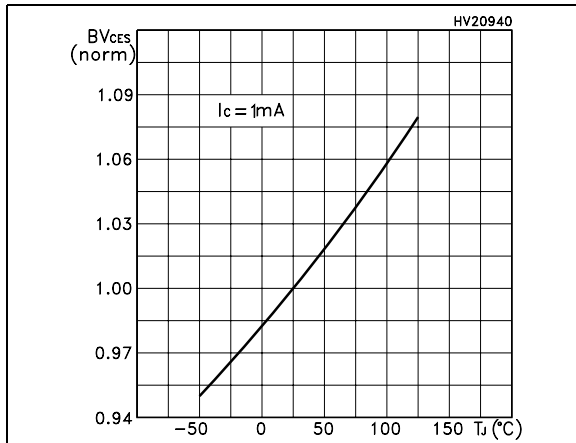


Figure 9. Gate charge vs gate-emitter voltage

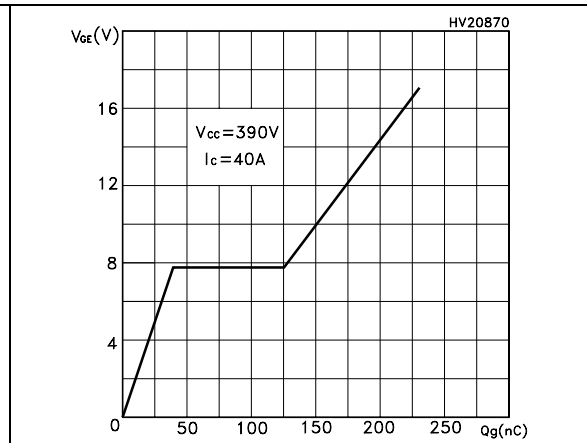


Figure 10. Capacitance variations

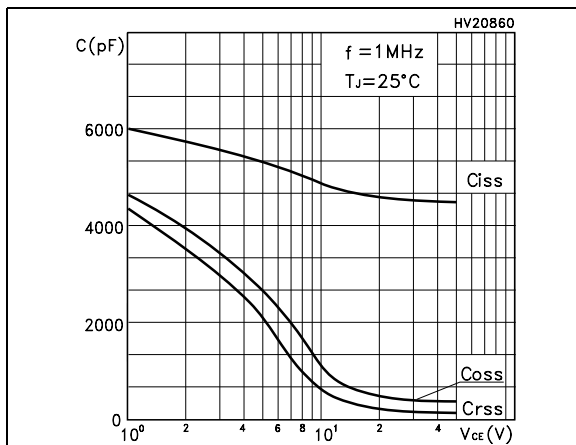


Figure 11. Total switching losses vs temperature

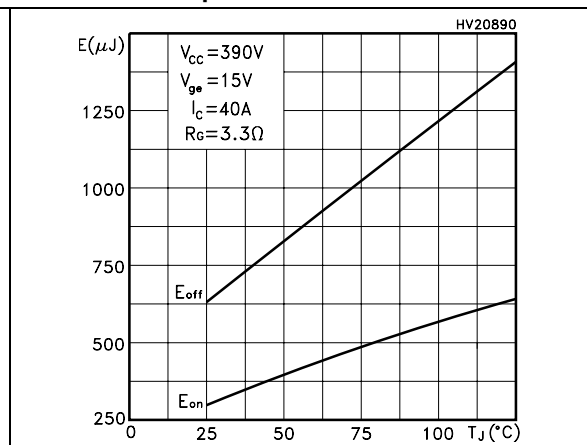


Figure 12. Total switching losses vs gate charge resistance

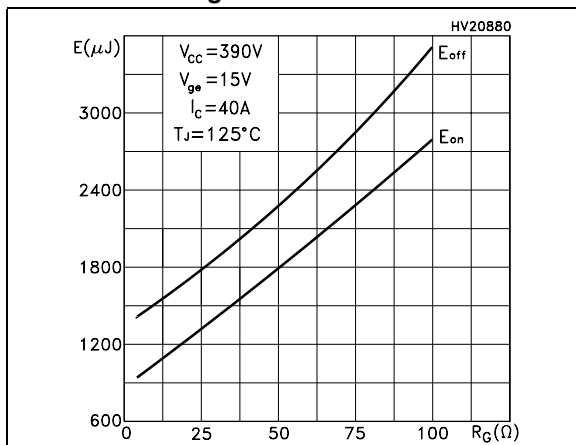


Figure 13. Total switching losses vs collector current

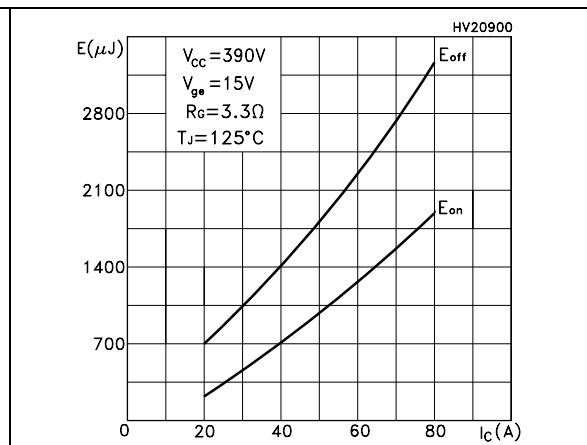




Figure 14. Turn-off SOA

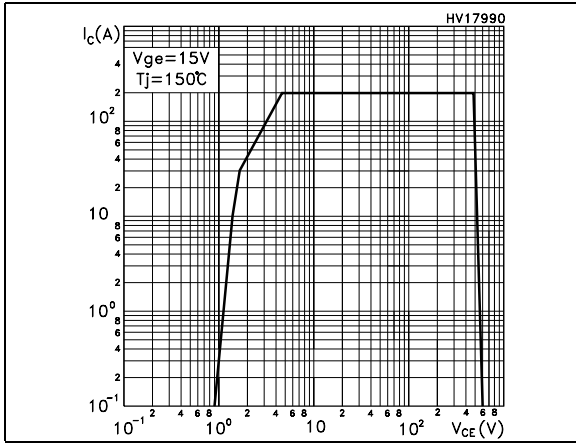
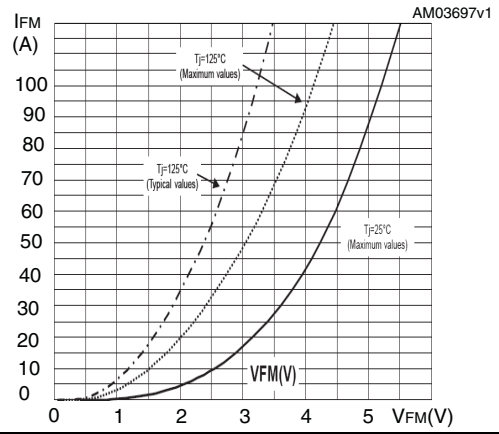


Figure 15. Emitter-collector diode characteristics



### 3 Test circuits

Figure 16. Test circuit for inductive load switching

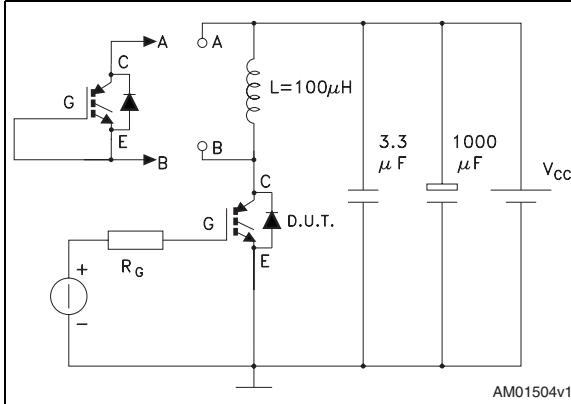


Figure 17. Gate charge test circuit

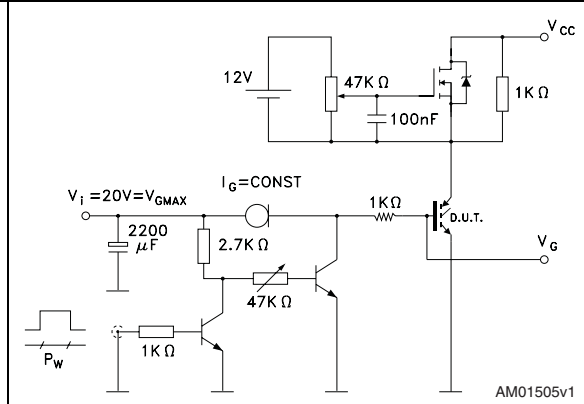


Figure 18. Switching waveform

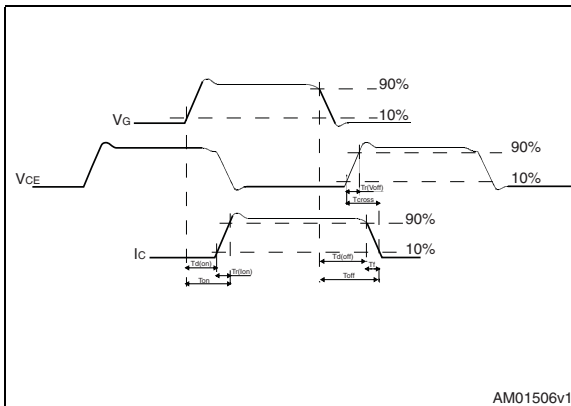
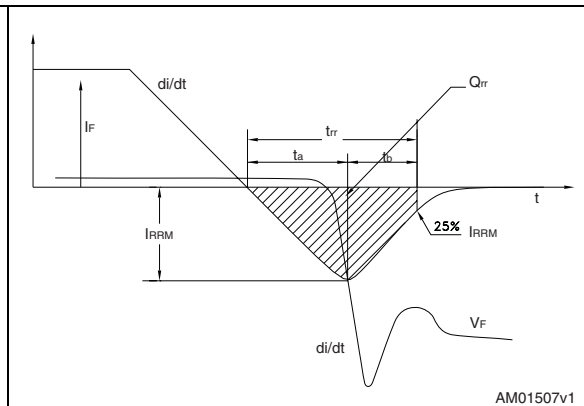


Figure 19. Diode recovery time waveform



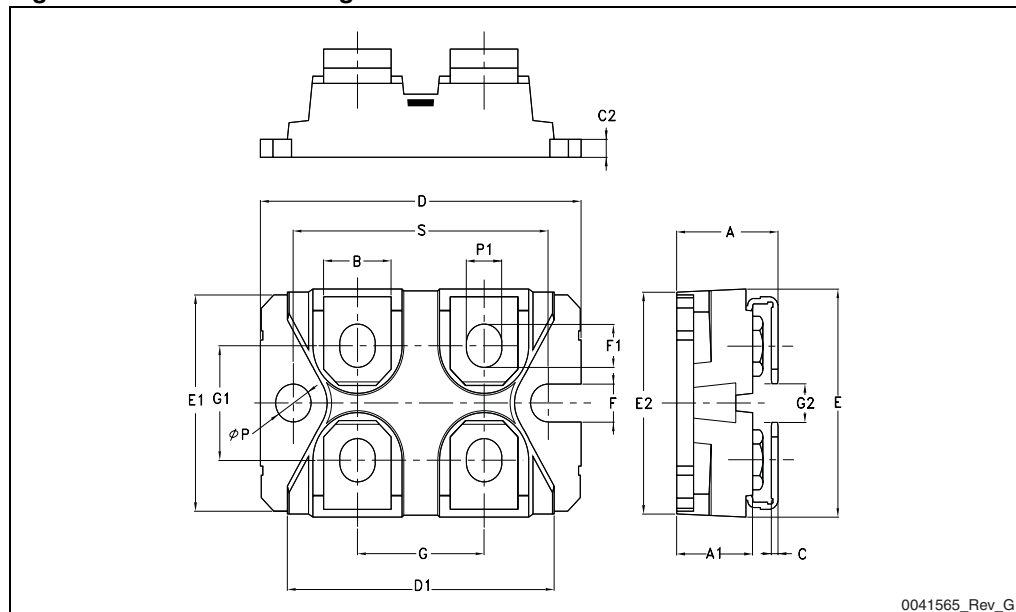
## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK is an ST trademark.

Table 9. ISOTOP mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A	11.80		12.20
A1	8.90		9.10
B	7.80		8.20
C	0.75		0.85
C2	1.95		2.05
D	37.80		38.20
D1	31.50		31.70
E	25.15		25.50
E1	23.85		24.15
E2		24.80	
G	14.90		15.10
G1	12.60		12.80
G2	3.50		4.30
F	4.10		4.30
F1	4.60		5
∅P	4		4.30
P1	4		4.40
S	30.10		30.30

Figure 20. ISOTOP drawing



0041565\_Rev\_G

## 5 Revision history

**Table 10. Document revision history**

Date	Revision	Changes
11-Oct-2006	1	First release
24-Jul-2007	2	Internal schematic diagram has been updated <i>Figure 1</i>
23-Apr-2009	3	Updated: mechanical data

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